Search Notes



Application/Control I	10
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Applicant(s)/Patent Under Reexamination

SONI ET AL.

Examiner

Art Unit

Flores, Leon

2611

SEARCHED

Class	Subclass	Date	Examiner
375	355	2/15/2007	LF
370	206, 338	2/15/2007	LF

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of claim 1	2/20/2007	LF
Search in NPL (IEEE)	2/15/2007	LF
Checked for possible Double Patenting.	2/15/2007	LF
Consulted with SPE David Payne in regards to the amendments.	9/7/2007	LF
Consulted with SPE David Payne in regards to the amendments.	12/11/2007	LF
Consulted with SPE Shuwang Liu in regards to the RCE.	2/8/2008	LF
Consulted with SPE David Payne in regards to the RCE.	2/21/2008	LF
Consulted with SPE David Payne in regards to the amendments.	10/10/2008	LF
Consulted with SPE Shuwang Liu in regards to the amendment.	6/2/2009	LF
Consulted with SPE David Payne in regards to the Appeal.	1/21/2010	LF

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
375	354, 362	1/21/2010	LF
370	206, 338	1/21/2010	LF
327	149, 158	1/21/2010	LF
365	194, 239	1/21/2010	LF

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